Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/742,919	LEE ET AL.
Examiner	Art Unit
Tai Duong	2871

SEARCHED						
Class	;	Subclass	Date		Examiner	
349		110	8/21/2006		TD	
		111				
		141				
		153				
		156				
		190				
430		20				
		321				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (US PGPUB, USPAT, EPO, JPO, DERWENT, IBM TDB) see search history printout	8/21/2006	TD